TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74VHC273F,TC74VHC273FT,TC74VHC273FK

Octal D-Type Flip-Flop with Clear

The TC74VHC273 is an advanced high speed CMOS OCTAL D-TYPE FLIP FLOP fabricated with silicon gate C²MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

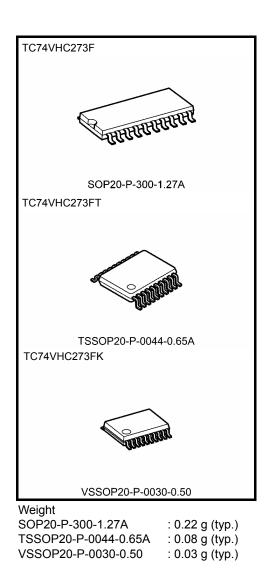
Information signals applied to D inputs are transferred to the Q outputs on the positive going edge of the clock pulse.

When the $\overline{\text{CLR}}$ input is held "L", the Q outputs are at a low logic level independent of the other inputs.

An input protection circuit ensures that 0 to 5.5 V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5 V to 3 V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

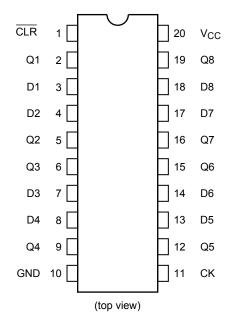
Features

- High speed: $f_{max} = 165 \text{ MHz}$ (typ.) at $V_{CC} = 5 \text{ V}$
- Low power dissipation: $I_{CC} = 4 \mu A (max)$ at $Ta = 25^{\circ}C$
- High noise immunity: $V_{\text{NIH}} = V_{\text{NIL}} = 28\% V_{\text{CC}}$ (min)
- Power down protection is provided on all inputs.
- Balanced propagation delays: $t_{pLH} \simeq t_{pHL}$
- Wide operating voltage range: V_{CC} (opr) = 2 to 5.5 V
- Low noise: $V_{OLP} = 0.9 V (max)$
- Pin and function compatible with 74ALS273



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Pin Assignment



IEC Logic Symbol

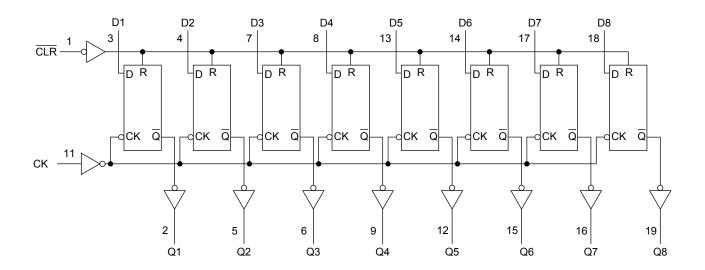
| $\frac{\overline{CLR}}{CK} \underbrace{(1)}_{CK}$ | R >C1 | (2) 01 |
|---|----------|----------------------------------|
| D1 <u>(3)</u> D2 <u>(4)</u> | 1D | (<u>2)</u> Q1 (<u>5)</u> Q2 |
| D3 <u>(7)</u> | | <u>(6)</u> Q3 |
| D4 <u>(8)</u> | | (<u>9)</u> Q4 (12) Q5 |
| D5 <u>(13)</u> D6 <u>(14)</u> | | (12) Q5 (15) Q6 |
| D6 D7(17) | | (<u>16)</u> Q7 |
| D8 <u>(18)</u> | | (19) Q8 |

Truth Table

| | Inputs | Function | | |
|-----|--------|----------|----------------|-----------|
| CLR | D | СК | Q | FUNCTION |
| L | Х | Х | L | Clear |
| Н | L | | L | — |
| Н | Н | | Н | — |
| Н | Х | | Q _n | No Change |

X: Don't care

System Diagram



Absolute Maximum Ratings (Note)

| Characteristics | Symbol | Rating | Unit |
|------------------------------------|------------------|-------------------------------|------|
| Supply voltage range | V _{CC} | –0.5 to 7.0 | V |
| DC input voltage | V _{IN} | -0.5 to 7.0 | V |
| DC output voltage | V _{OUT} | -0.5 to V _{CC} + 0.5 | V |
| Input diode current | I _{IK} | -20 | mA |
| Output diode current | I _{ок} | ±20 | mA |
| DC output current | IOUT | ±25 | mA |
| DC V _{CC} /ground current | ICC | ±75 | mA |
| Power dissipation | PD | 180 | mW |
| Storage temperature | T _{stg} | -65 to 150 | °C |

Note: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Operating Ranges (Note)

| Characteristics | Symbol | Rating | Unit | |
|--------------------------|------------------|-------------------------------------|------|--|
| Supply voltage | V _{CC} | 2.0 to 5.5 | V | |
| Input voltage | V _{IN} | 0 to 5.5 | V | |
| Output voltage | V _{OUT} | 0 to V _{CC} | V | |
| Operating temperature | T _{opr} | -40 to 85 | °C | |
| Input rise and fall time | dt/dv | 0 to 100 (V_{CC} = 3.3 \pm 0.3 V) | 201 | |
| Input rise and fall time | uluv | 0 to 20 (V_{CC} = 5 \pm 0.5 V) | ns/V | |

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

Electrical Characteristics

DC Characteristics

| Characteristics | Symbol | Test Condition | | | ٦ | Га = 25°(| 2 | Ta = -40 to 85°C | | Unit |
|---------------------------------------|-----------------|---|--------------------------|---------------|-----------------------|-----------|-----------------------|-----------------------|-----------------------|------|
| | , | | | | Min | Тур. | Max | Min | Max | |
| High-level input | evel input | | | 2.0 | 1.50 | | _ | 1.50 | _ | |
| voltage | V _{IH} | — | | 3.0 to 5.5 | V _{CC} × 0.7 | _ | _ | V _{CC} × 0.7 | _ | V |
| Low-level input | | | | 2.0 | _ | _ | 0.50 | _ | 0.50 | |
| voltage | VIL | | | 3.0 to 5.5 | _ | — | V _{CC} × 0.3 | — | V _{CC} × 0.3 | V |
| | V _{OH} | | | 2.0 | 1.9 | 2.0 | — | 1.9 | — | |
| | | VIN = VIH or VIL | I _{OH} = -50 μA | 3.0 | 2.9 | 3.0 | — | 2.9 | — | |
| High-level output voltage | | | | 4.5 | 4.4 | 4.5 | — | 4.4 | — | V |
| Ũ | | | $I_{OH} = -4 \text{ mA}$ | 3.0 | 2.58 | _ | _ | 2.48 | _ | |
| | | | I _{OH} = -8 mA | 4.5 | 3.94 | — | — | 3.80 | — | |
| | | | | 2.0 | — | 0.0 | 0.1 | _ | 0.1 | |
| | | | $I_{OL} = 50 \ \mu A$ | 3.0 | — | 0.0 | 0.1 | — | 0.1 | |
| Low-level output voltage | V _{OL} | V _{IN} = V _{IH} or V _{IL} | | 4.5 | — | 0.0 | 0.1 | _ | 0.1 | V |
| , , , , , , , , , , , , , , , , , , , | | | $I_{OL} = 4 \text{ mA}$ | 3.0 | — | — | 0.36 | _ | 0.44 | |
| | | | I _{OL} = 8 mA | 4.5 | — | — | 0.36 | — | 0.44 | |
| Input leakage current | I _{IN} | V _{IN} = 5.5 V or GND | | 0 to 5.5 | _ | _ | ±0.1 | _ | ±1.0 | μA |
| Quiescent supply current | ICC | V _{IN} = V _{CC} or | GND | 5.5 | | | 4.0 | | 40.0 | μΑ |

Timing Requirements (input: $t_r = t_f = 3 \text{ ns}$)

| Characteristics | Symbol Test Condition | | - | Ta = 25°C | | Ta = -40 to 85°C | Unit |
|--|-----------------------|---|-------------------------------|-----------|-------|------------------------|------|
| | | | V _{CC} (V) | Тур. | Limit | Limit | |
| Minimum pulse width (CIC) | t _{w (L)} | | $\textbf{3.3}\pm\textbf{0.3}$ | _ | 5.5 | 6.5 | |
| Minimum pulse width (CK) | t _{w (H)} | _ | 5.0 ± 0.5 | — | 5.0 | 5.0 | ns |
| Minimum pulse width (\overline{CLR}) | t _{w (L)} | — | $\textbf{3.3}\pm\textbf{0.3}$ | _ | 5.0 | 6.0 | ns |
| | | | 5.0 ± 0.5 | — | 5.0 | 5.0 | |
| | ts | — | $\textbf{3.3}\pm\textbf{0.3}$ | _ | 5.5 | 6.5 | ns |
| Minimum set-up time | | | 5.0 ± 0.5 | — | 4.5 | 4.5 | |
| Minimum hold time | t _h | — | $\textbf{3.3}\pm\textbf{0.3}$ | _ | 1.0 | 1.0 | |
| Minimum hold time | | | 5.0 ± 0.5 | — | 1.0 | 1.0 | ns |
| Minimum removal time (CLR) | t _{rem} | _ | $\textbf{3.3}\pm\textbf{0.3}$ | _ | 2.5 | 2.5 | |
| | | | 5.0 ± 0.5 | _ | 2.0 | 2.0 | ns |

AC Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

| Characteristics Symbol | Symbol | Tes | Test Condition | | Ta = 25°C | | | Ta = -40 to 85°C | | Unit | | | |
|-------------------------------|-------------------|----------|-------------------------------|---------------------|-----------|-----------|------|---------------------|------|-------|-----|------|----|
| | -) | | V _{CC} (V) | C _L (pF) | Min | Тур. | Max | Min | Max | | | | |
| | | | 3.3 ± 0.3 | 15 | _ | 8.7 | 13.6 | 1.0 | 16.0 | | | | |
| Propagation delay time | t _{pLH} | | 5.5 ± 0.5 | 50 | _ | 11.2 | 17.1 | 1.0 | 19.5 | ns | | | |
| (CK-Q) | t _{pHL} | | 5.0 ± 0.5 | 15 | _ | 5.8 | 9.0 | 1.0 | 10.5 | 115 | | | |
| | | | 5.0 ± 0.5 | 50 | _ | 7.3 | 11.0 | 1.0 | 12.5 | | | | |
| | | | 3.3 ± 0.3 | 15 | _ | 8.9 | 13.6 | 1.0 | 16.0 | | | | |
| Propagation delay time | t | | | | | 5.5 ± 0.5 | 50 | _ | 11.4 | 17.1 | 1.0 | 19.5 | ns |
| (CLR -Q) | чрНL | | 5.0 ± 0.5 | 15 | _ | 5.2 | 8.5 | 1.0 | 10.0 | - 115 | | | |
| | | | | 50 | _ | 6.7 | 10.5 | 1.0 | 12.0 | | | | |
| | | | 3.3 ± 0.3 | 15 | 75 | 120 | _ | 65 | _ | | | | |
| Maximum clock | f _{max} | | 0.0 ± 0.0 | 50 | 50 | 75 | _ | 45 | _ | MHz | | | |
| frequency | ımax | | 5.0 ± 0.5 | 15 | 120 | 165 | _ | 100 | _ | | | | |
| | | | 5.0 ± 0.5 | 50 | 80 | 110 | _ | 70 | _ | | | | |
| Output to output skew | t _{osLH} | (Note 1) | $\textbf{3.3}\pm\textbf{0.3}$ | 50 | | | 1.5 | | 1.5 | ns | | | |
| | t _{osHL} | (Note T) | 5.0 ± 0.5 | 50 | _ | _ | 1.0 | _ | 1.0 | 115 | | | |
| Input capacitance | C _{IN} | | _ | | | 4 | 10 | | 10 | pF | | | |
| Power dissipation capacitance | C _{PD} | | | (Note 2) | | 31 | | | _ | pF | | | |

Note 1: Parameter guaranteed by design.

 $t_{osLH} = |t_{pLHm} - t_{pLHn}|, t_{osHL} = |t_{pHLm} - t_{pHLn}|$

Note 2: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8$ (per bit)

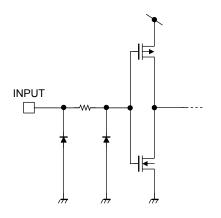
And the total C_{PD} when n pcs.of flip flop operate can be gained by the following equation:

C_{PD} (total) = 22 + 9·n

Noise Characteristics (input: $t_r = t_f = 3 \text{ ns}$)

| Characteristics | Symbol | Test Condition | | Ta = | Unit | |
|--|------------------|------------------------|---------------------|------|------|------|
| | Symbol | | V _{CC} (V) | Тур. | Max | Unit |
| Quiet output maximum dynamic V_{OL} | V _{OLP} | C _L = 50 pF | 5.0 | 0.5 | 0.8 | V |
| Quiet output minimum dynamic V _{OL} | V _{OLV} | C _L = 50 pF | 5.0 | -0.5 | -0.8 | V |
| Minimum high level dynamic input voltage | V _{IHD} | C _L = 50 pF | 5.0 | _ | 3.5 | V |
| Maximum low level dynamic input voltage | V _{ILD} | $C_L = 50 \text{ pF}$ | 5.0 | | 1.5 | V |

Input Equivalent Circuit

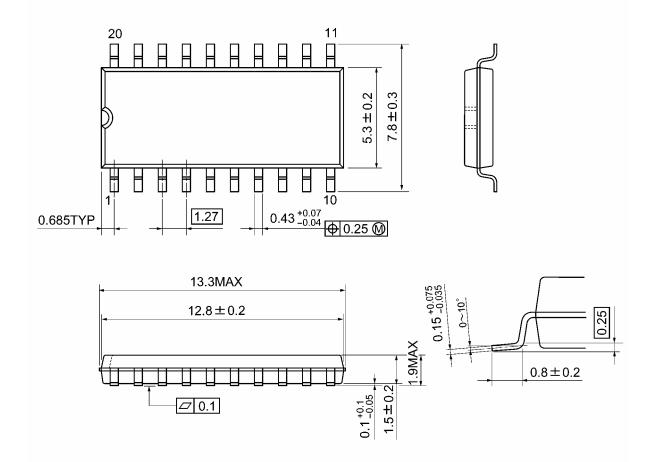




Package Dimensions

SOP20-P-300-1.27A

Unit: mm



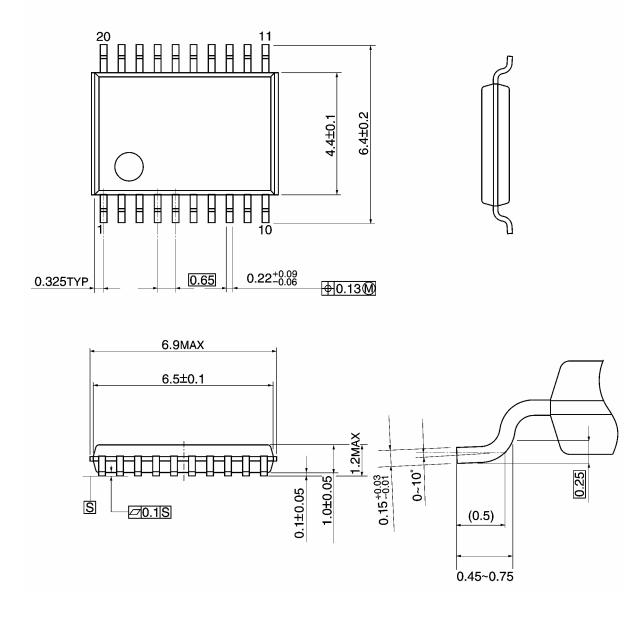
Weight: 0.22 g (typ.)

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Package Dimensions

TSSOP20-P-0044-0.65A

Unit: mm



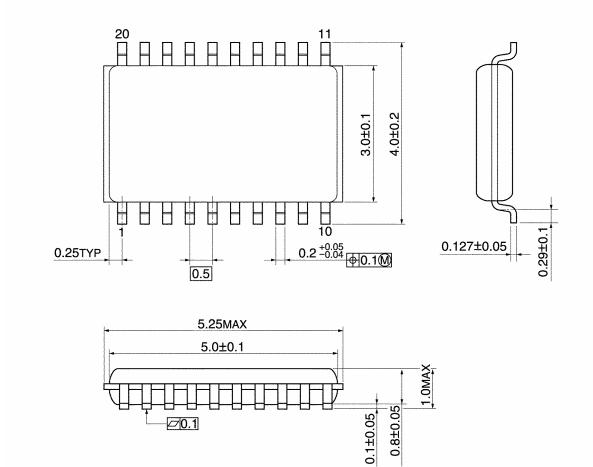
Weight: 0.08 g (typ.)

TOSHIBA

Package Dimensions

VSSOP20-P-0030-0.50

Unit: mm



Weight: 0.03 g (typ.)

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20070701-EN GENERAL

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